

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 4459-090A		U.S. PATENT APPLICATION NO. -----	
				APPLICANT Po Jen CHENG <i>et al.</i>			
				FILING DATE February 10, 2004		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
<i>J. H.</i> ↓	5,840,417	11-1998	Bolger				
	6,020,633	02-2000	Erickson				
	6,040,530	03-2000	Wharton <i>et al.</i>				
	6,121,554	09-2000	Kamikawa				
	6,326,555	12-2001	McCormack <i>et al.</i>				
	6,400,174	06-2002	Akram <i>et al.</i>				
	6,483,329	11-2002	Cram				
	6,535,005	03-2003	Field				
	5,440,239	08-1995	Zappella <i>et al.</i>				
	5,801,536	09-1998	Brambilla <i>et al.</i>				
	6,075,710	06-2000	Lau				
	6,288,559	09-2001	Bernier <i>et al.</i>				
	6,564,986	05-2003	Hsieh				
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>Jel. H. H. H.</i>				DATE CONSIDERED <i>6/25/04</i>			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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